### **Power MOSFET**

# 40 V, 167 A, Single N-Channel, D<sup>2</sup>PAK & TO-220

#### **Features**

- Low R<sub>DS(on)</sub>
- High Current Capability
- Low Gate Charge
- AEC-Q101 Qualified and PPAP Capable NVB5404N
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paran	Symbol	Value	Units		
Drain-to-Source Voltage	V <sub>DSS</sub>	40	V		
Gate-to-Source Voltage	е		$V_{GS}$	±20	V
Continuous Drain	Steady	T <sub>C</sub> = 25°C	I <sub>D</sub>	167	Α
Current – R <sub>θJC</sub>	State	T <sub>C</sub> = 100°C		118	
Power Dissipation – $R_{\theta JC}$	Steady State	T <sub>C</sub> = 25°C	P <sub>D</sub>	254	W
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	24	Α
Current – R <sub>θJA</sub> (Note 1)	State	T <sub>A</sub> = 100°C	1	17	
Power Dissipation – R <sub>θJA</sub> (Note 1)	Steady State T <sub>A</sub> = 25°C		P <sub>D</sub>	5.4	W
Pulsed Drain Current	t <sub>p</sub> :	= 10 μs	I <sub>DM</sub>	670	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 175	°C
Source Current (Body Diode) Pulsed			I <sub>S</sub>	75	Α
Single Pulse Drain–to Source Avalanche Energy – ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_{PK}$ = 45 A, L = 1 mH, $R_G$ = 25 $\Omega$ )			EAS	1000	mJ
Lead Temperature for S (1/8" from case for 10 s		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	0.59	°C/W
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	50	°C/W

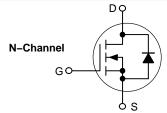
Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

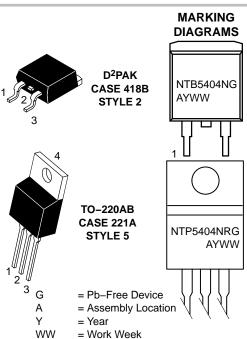


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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX (Note 1)
40 V	4.5 mΩ @ 10 V	167 A





#### ORDERING INFORMATION

Device	Package	Shipping†
NTB5404NT4G	D <sup>2</sup> PAK (Pb-Free)	800 / Tape & Reel
NTP5404NRG	TO-220 (Pb-Free)	50 Units / Rail
NVB5404NT4G	D <sup>2</sup> PAK (Pb-Free)	800 / Tape & Reel

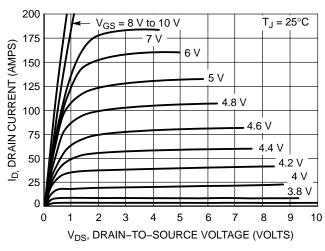
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Test Cond	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D$	= 250 μΑ	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				34		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		$V_{DS} = 40 \text{ V}$	T <sub>J</sub> = 100°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{G}$	<sub>S</sub> = ±30 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		3.5	V
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-8.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I	<sub>D</sub> = 40 A		3.5	4.5	mΩ
		$V_{GS} = 5.0 \text{ V},$	I <sub>D</sub> = 15 A		5.1	7.0	
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I	<sub>D</sub> = 15 A		35		S
CHARGES AND CAPACITANCES	•				•	•	
Input Capacitance	C <sub>ISS</sub>				4300	7000	pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = V_{DS} = 3$	1.0 MHz,		1075	1700	
Reverse Transfer Capacitance	C <sub>RSS</sub>	VDS = 32 V			450	1000	
Total Gate Charge	Q <sub>G(TOT)</sub>				125		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 10 V. V <sub>I</sub>	ns = 32 V.		5.5		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 10 \text{ V}, V_{I}$ $I_{D} = 40$	ÎĂ ,		12.5		
Gate-to-Drain Charge	$Q_{GD}$		-		55		
SWITCHING CHARACTERISTICS, Vo	<sub>SS</sub> = 10 V (Note	3)				•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				10		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V. V <sub>I</sub>	nn = 32 V.		65		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 10 \text{ V}, V_{I}$ $I_{D} = 40 \text{ A}, R_{C}$	$_{\rm G} = 2.5  \Omega$		85		1
Fall Time	t <sub>f</sub>				85		
SWITCHING CHARACTERISTICS, Vo	<sub>iS</sub> = 5 V (Note 3	)				•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				25		ns
Rise Time	t <sub>r</sub>	$V_{GS} = 5 \text{ V}, V_{D}$	n = 20 V.		175		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 20 \text{ A}, R_G = 2.5 \Omega$			46		
Fall Time	t <sub>f</sub>				62		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS		•				
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	1.1	V
		$V_{GS} = 0 V,$ $I_{S} = 20 A$	T <sub>J</sub> = 125°C		0.65		7
Reverse Recovery Time	t <sub>RR</sub>				75		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } dI_{SD}/d$	t = 100 A/μs,		38		
Discharge Time	t <sub>b</sub>	$I_S = 20$	Α ' ΄		38		7
Reverse Recovery Charge	Q <sub>RR</sub>				140		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

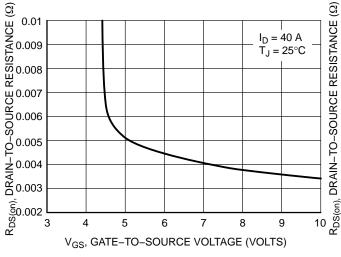
#### **TYPICAL PERFORMANCE CURVES**



200  $V_{DS} \ge 10 \text{ V}$ 175 ID, DRAIN CURRENT (AMPS) 150 125 100 75  $T_{.1} = 25^{\circ}C$ 50 25 125°C  $T_J = -55^{\circ}C$ 0 2 10 0 6 8 9 3 4 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



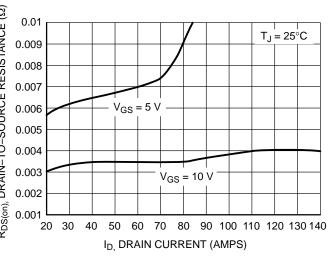
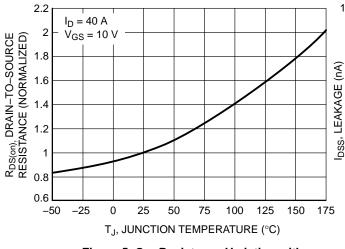


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



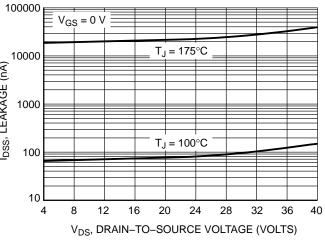
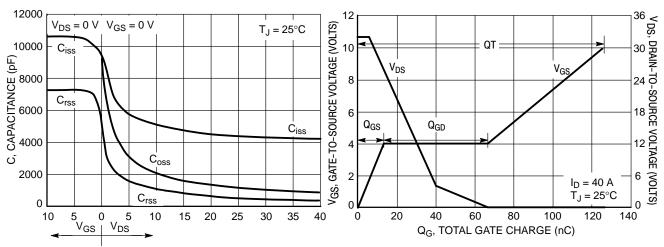


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

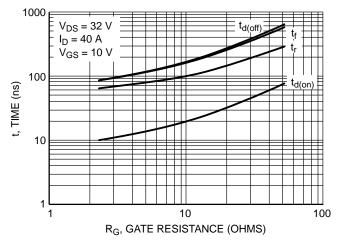


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

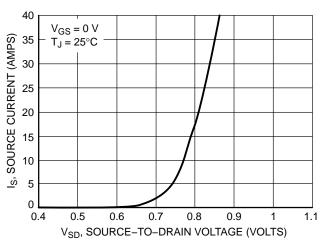


Figure 10. Diode Forward Voltage vs. Current

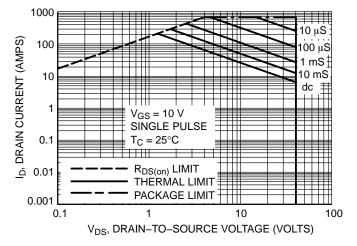


Figure 11. Maximum Rated Forward Biased Safe Operating Area

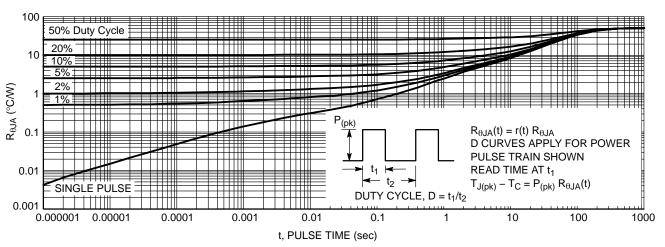
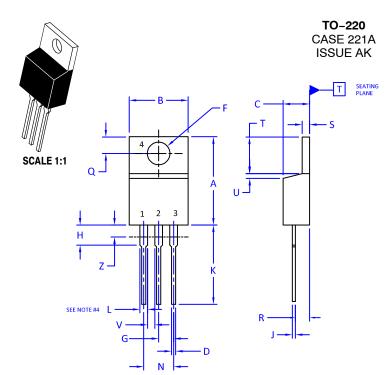


Figure 12. Thermal Response





**DATE 13 JAN 2022** 

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

#### 4. MAX WIDTH FOR F102 DEVICE = 1.35MM

	INCHES		MILLIMI	ETERS
DIM	MIN.	MAX.	MIN.	MAX.
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.60	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
J	0.014	0.024	0.36	0.61
К	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.41
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045		1.15	
Z		0.080		2.04

STYLE 1: PIN 1. 2. 3. 4.	COLLECTOR EMITTER	STYLE 2: PIN 1. 2. 3. 4.	BASE EMITTER COLLECTOR EMITTER	STYLE 3: PIN 1. 2. 3. 4.	ANODE	2. 3.	MAIN TERMINAL 1 MAIN TERMINAL 2 GATE MAIN TERMINAL 2
	GATE DRAIN SOURCE DRAIN	3.	ANODE CATHODE ANODE CATHODE	STYLE 7: PIN 1. 2. 3. 4.	ANODE	2. 3.	CATHODE ANODE EXTERNAL TRIP/DELA' ANODE
STYLE 9: PIN 1. 2. 3. 4.	GATE COLLECTOR EMITTER COLLECTOR			STYLE 11: PIN 1. 2. 3. 4.	DRAIN	STYLE 12: PIN 1. 2. 3. 4.	MAIN TERMINAL 1 MAIN TERMINAL 2 GATE NOT CONNECTED

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### **MECHANICAL CASE OUTLINE**

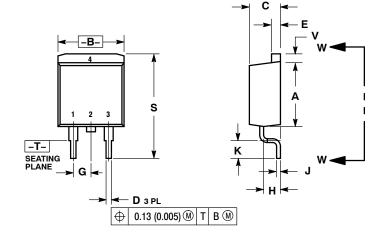




D<sup>2</sup>PAK 3 CASE 418B-04 **ISSUE L** 

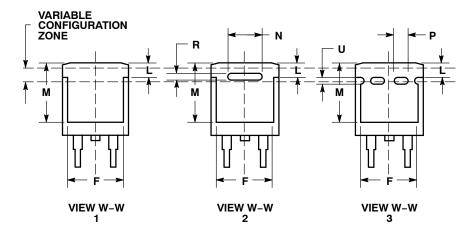
**DATE 17 FEB 2015** 

#### SCALE 1:1



- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: INCH.
- 3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
C	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
Е	0.045	0.055	1.14	1.40	
F	0.310	0.350	7.87	8.89	
G	0.100	BSC	2.54 BSC		
Н	0.080	0.110	2.03	2.79	
7	0.018	0.025	0.46	0.64	
K	0.090	0.110	2.29	2.79	
L	0.052	0.072	1.32	1.83	
M	0.280	0.320	7.11	8.13	
N	0.197 REF		5.00 REF		
Р	0.079 REF		2.00 REF		
R	0.039 REF		0.99	REF	
S	0.575	0.625	14.60	15.88	
٧	0.045	0.055	1.14	1.40	



STYLE 1: PIN 1. BASE 2. COLLECTOR
3. EMITTER
4. COLLECTOR STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN STYLE 3: PIN 1. ANODE 2. CATHODE 3. ANODE 4. CATHODE

STYLE 4:

PIN 1. GATE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

STYLE 5:

PIN 1. CATHODE 2. ANODE 3. CATHODE 4. ANODE

STYLE 6:

PIN 1. NO CONNECT
2. CATHODE
3. ANODE
4. CATHODE

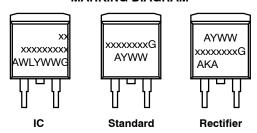
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**DATE 17 FEB 2015** 

# GENERIC MARKING DIAGRAM\*



xx = Specific Device Code A = Assembly Location

 WL
 = Wafer Lot

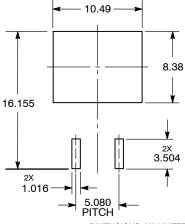
 Y
 = Year

 WW
 = Work Week

 G
 = Pb-Free Package

 AKA
 = Polarity Indicator

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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present.

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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